



## Crystal

SMD3225-16M0820F

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## ■ ELECTRICAL SPECIFICATIONS

### Standard atmospheric conditions

Unless otherwise specified. The standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature :  $25 \pm 5$

Relative humidity: 40%~70%

If there is no doubt the results, measurement shall be made within the following limits:

Ambient temperature :  $25 \pm 1$

Relative humidity: 40%~70%

### Measure equipment

Electrical characteristics measured by S&A 250B or equivalent.

### Crystal cutting type

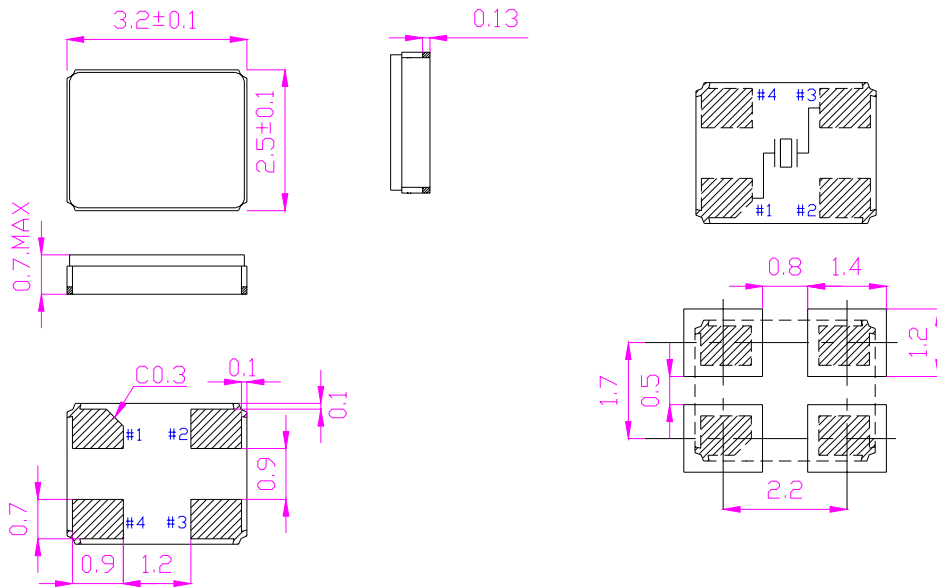
The crystal is using AT CUT (thickness shear mode)

	Parameters	SYM	Electrical spec.	UNITS	Notes
1	Nominal Frequency	FL	16	MHz	-
2	Oscillation Mode	-	Fund	-	-
3	Load Capacitance	CL	8	pF	-
4	Frequency Tolerance	-	$\pm 20$	ppm	MAX
5	Frequency Tolerance	-	$\pm 30$	ppm	Over Operating Temp. Range (Reference 25 )
6	Operating Temperature	-	-10 ~ +50		-
7	Aging	-	$\pm 3$	ppm	1st Year
8	Drive Level	DL	100	$\mu$ W	-
9	Effective Resistance Rr	Rr	60		MAX
10	Shunt Capacitance C0	C0	7max	pF	-
11	Motional Capacitance C1	C1	-	fF	-
12	Spurious Response	SPDB	-	dB	The spec. is <-3dB(Max.) Within +/-5000ppm of normal Freq. unless otherwise specified.
13	Insulation Resistance	-	500	M	at DC 100V
14	Storage Temperature Range	-	-55 ~ +125		-
15	Others	-	-	-	-

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■ **DIMENSION**

1. Crystal enclosure seal : Seam Weld
2. Crystal enclosure medium : Vacuum



■ **MARKING**

Ref. Purchase Specification

■ **SHELF LIFE & STORAGE CONDITIONS**

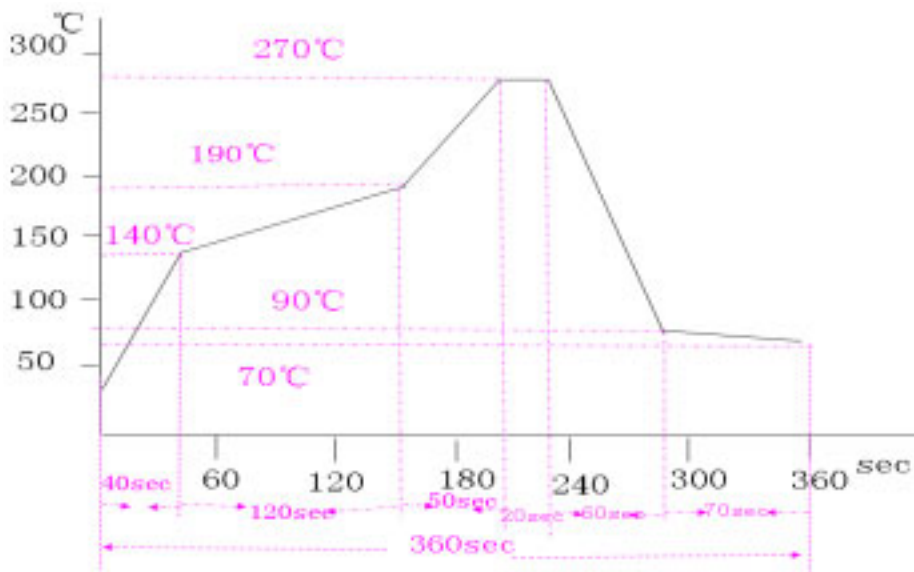
No shipment is allowed by manufactured over 1 year .

Storage Conditions:

Temp.	Humidity
25 ± 3	40~60%

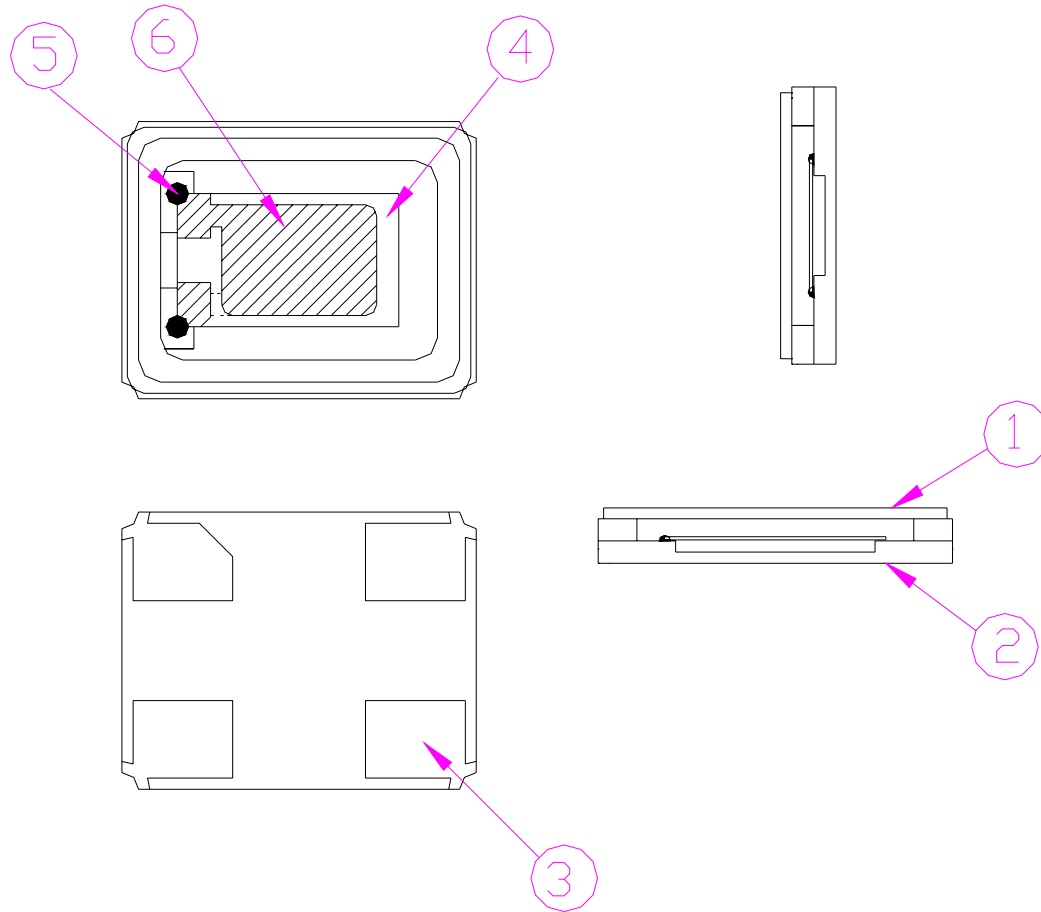
■ **SUGGESTED REFLOW PROFILE**

Total time : 360sec.Max.



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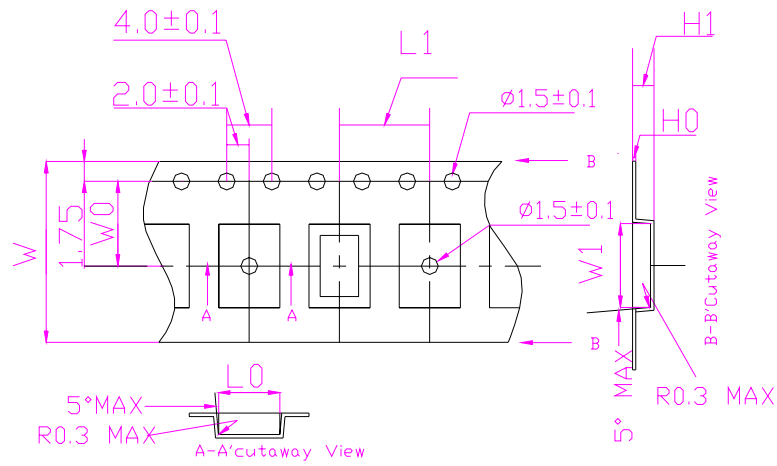
■ STRUCTURE ILLUSTRATION



NO	COMPONENTS	MATERIALS	QTY	FINISH/SPECIFICATIONS
1	Cap	Metal (Fe)	1	-
2	Base	Ceramic	1	Color black
3	PAD	Au	4	Tungsten metalize +Ni plating +Au plating
4	Crystal blank	SiO <sub>2</sub>	1	-
5	Conductive adhesive	Ag	4	Epoxy resin
6	Electrode	Ag + Cr	2	-

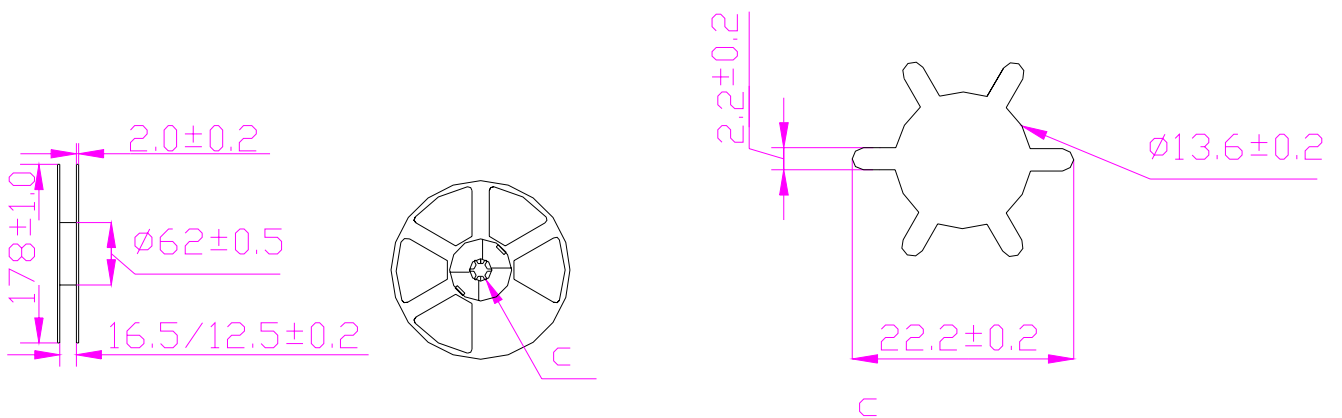
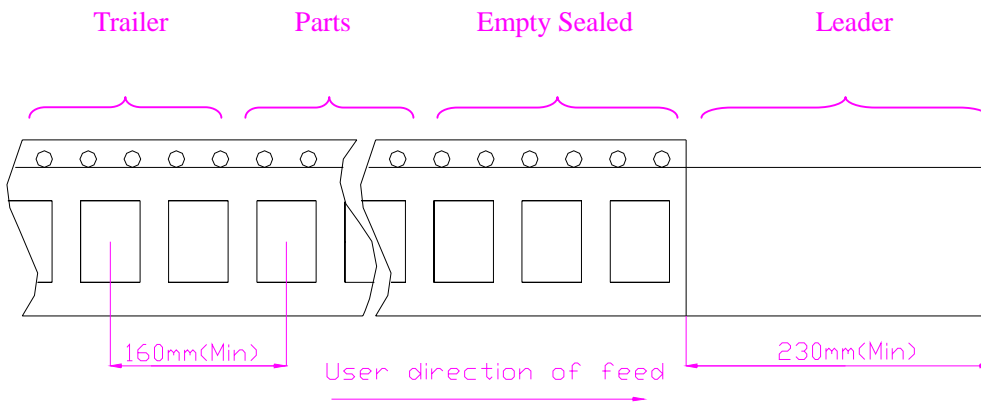
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- **PACKING: (EIA-481-2)**
  - Shear strength between cover and carrier tape should be 30-100g.
  - Carrier tape should be folded over three times with no break at all.



Specification	Symbol	Dimension Tolerance (mm)						
		W	W0	W1	L0	L1	H0	H1
3225-12		12 ± 0.3	5.5 ± 0.1	3.6 ± 0.1	2.9 ± 0.1	8.0 ± 0.1	0.3 ± 0.05	1.2 ± 0.1

**REMARK:**

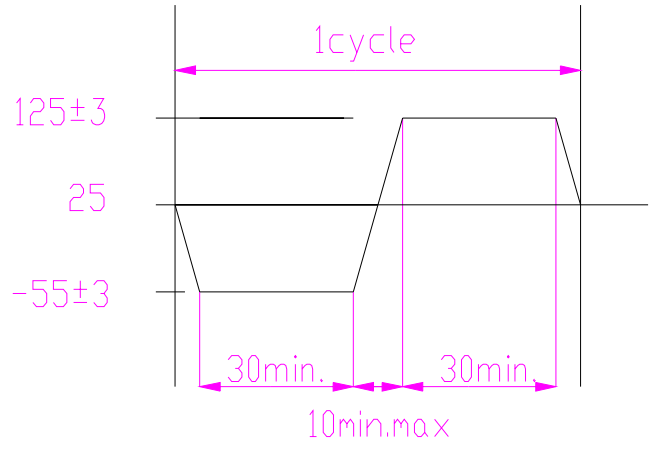


Unit : mm

Standard Reel Quantity is 1,000 pcs per reel.



■ RELIABILITY SPECIFICATIONS

NO	Test Item	Test Methods	Ref.Doc
1	Drop test	75 cm height, fall freely onto stainless plate 3times.	-
2	Mechanical Shock	Device are shocked to half sine wave (1000G) three mutually pendicular axes each 3 times.0.5sec.duration time.	-
3	Vibration	Frequency range 10~2000Hz Amplitude 1.52mm Sweep time 20 minute Pendicular axes each test time 4 hours (Total test time 12 hours)	-
4	Solderability	Temperature 255 ± 5 Immersing depth 0.5mm minimum Immersion time 10 ± 0.5seconds Flux Rosin resin methyl alcohol Solvent (1:4)	-
5	Resistance To Soldering Heat	Pre-heat temperature 125 Pre-heat time 60~120sec. Test temperature 260 ± 5 Test time 5 ± 1sec.	-
6	High Temp. Storage	+125 ± 2 for 1000 ± 12hours	-
7	Low temp. Storage	-40 ± 2 for 1000 ± 12hours	-
8	Thermal Cycles	Total 100 cycles of the following temperature cycle   <p>The diagram illustrates a thermal cycle with the following parameters:          - High temperature: 125 ± 3          - Low temperature: -55 ± 3          - Dwell time at high temperature: 30 min.          - Dwell time at low temperature: 30 min.          - Transition time (ramp): 10 min. max.          - One complete cycle is indicated by a double-headed arrow.</p>	-

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## 环境管理物质使用规范

### Specification of the environment-related substances

范围 Range	产品 Products	包材 Packing Material	Test Method
禁限物质 Banned Substances	最高含量 Maximum concentration ppm(mg/kg)	最高含量 Maximum concentration ppm(mg/kg)	
1.镉及镉化合物 Cadmium and cadmium compounds	5	5	ICP-AES as per EN1122, method B2001 or other acid digestion.
2.铅及铅化合物 Lead and lead compounds	40	100	ICP-AES after as per EPA 3050B or other acid digestion.
3.汞及汞化合物 Mercury and mercury compounds	5	5	ICP-AES after as per EPA 3052 or other acid digestion.
4.六价铬化合物 Hexavalent-Chromium VI (Cr <sup>+6</sup> )	10	10	As per US EPA 7196A and US EPA 3060A.
5.聚溴联苯 PBB Polybrominated biphenyls	5	5	With reference to USEPA 3540 or USEPA3550. Analysis was performed by LPLC/DAD, LC/MS or GC/MS. (prohibited by 2002/95/EC (RoHS),83/261/EEC, and76/769/EEC)
6.聚溴二苯醚 PBDE Polybrominated diphenyl ethers	5	5	With reference to USEPA3540or USEPA3550. Analysis was performed by HPLC/DAD LC/MS or GC/MS.(prohibited by 2002/95/EC(RoHS), 83/264/EEC, and 76/769/EEC)
7.多氯联苯 (PCB) Polychlorinated biphenyl	5	5	
8.多氯化萘 (PCN) Polychlorinated naphthalene	5	5	
9.氯代烷烃 (CP) Chlorinated paraffin	5	5	
10.其他有机氯化物 Other chlorinated organic compounds	5	5	
11.其他有机溴化合物 Other brominated organic compounds	5	5	
12.有机锡化合物 (三丁基锡化合物,三苯基锡化合物) Organic tin compounds (Tributyl tin category & Triphenyl tin category )	5	5	
13.石棉 Asbestos	5	5	
14.偶氮化合物 Azo compounds	5	5	
15.甲醛 Formaldehyde	5	5	
16.聚氯乙烯(PVC)以及聚氯乙烯混合物 Polyvinyl chloride (PVC) and PVC blends	No detect	No detect	
17.包装材料中重金属(汞、镉、六价铬、铅、PBB、PBDE)之总量 Heavy metals (mercury, cadmium, lead, Cr <sup>+6</sup> ,PBB and PBDE) in packing materials	N/A	<100	

Lead Free Products are “Directive 2002/95/EC of The European Parliament of 27 January 2003 on the restriction of certain hazardous substances (RoHS) in electrical and electronic equipment” and Sony SS-00259 Compliant.

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